

Notice of References Cited	Application/Control No. 09/963,533	Applicant(s)/Patent Under Reexamination ARAI, TAKAO	
	Examiner Johannes P Mondt	Art Unit 2826	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-4,939,390	07-1990	Coe, T.	307/450
	C	US-			
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	M	US-			

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.